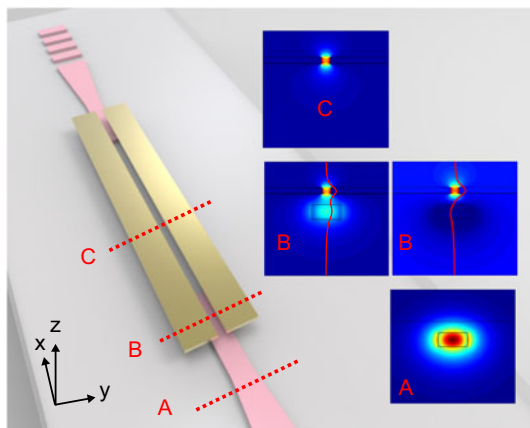


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George Dabos  
Dimitra Ketzaki  
Athanasios Manolis  
Evaggelia Chatzianagnostou  
Laurent Markey  
Jean-Claude Weeber  
Alain Dereux  
Anna Lena Giesecke  
Caroline Porschatis  
Bartos Chmielak  
Dimitris Tsiokos  
Nikos Pleros



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George Dabos <sup>1</sup>, Dimitra Ketzaki,<sup>1</sup> Athanasios Manolis,<sup>1</sup>  
Evaggelia Chatzianagnostou <sup>1</sup>, Laurent Markey,<sup>2</sup>  
Jean-Claude Weeber,<sup>2</sup> Alain Dereux,<sup>2</sup> Anna Lena Giesecke,<sup>3</sup>  
Caroline Porschatis,<sup>3</sup> Bartos Chmielak,<sup>3</sup> Dimitris Tsiokos,<sup>1</sup>  
and Nikos Pleros <sup>1</sup>

<sup>1</sup>Department of Informatics, Center for Interdisciplinary Research and Innovation, Aristotle University of Thessaloniki, Thessaloniki 57001, Greece

<sup>2</sup>Laboratoire Interdisciplinaire Carnot de Bourgogne, UMR 6303 CNRS, Université Bourgogne Franche Comté, Dijon 21078, France

<sup>3</sup>AMO GmbH, Advanced Microelectronic Center Aachen, Aachen 52074, Germany

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**Abstract:** We demonstrate a water cladded plasmo-photonic waveguide, by exploiting the directional coupling scheme to vertically divert light from a  $360 \times 800$  nm (height  $\times$  width) Si<sub>3</sub>N<sub>4</sub> waveguide to a plasmonic slot waveguide, enabling the excitation of a pure plasmonic mode within a 210-nm-wide slot at 1550 nm. The 150-nm-thick plasmonic slot waveguide was deposited on the top of an oxide cladded Si<sub>3</sub>N<sub>4</sub> waveguide exhibiting an experimental plasmonic-to-photonic insertion loss of  $2.24 \pm 0.3$  dB and a plasmonic propagation length ( $L_{\text{spp}}$ ) of  $10.8 \mu\text{m}$  at 1550 nm. The proposed plasmo-photonic waveguide holds a promise as an optical transducer element for highly sensitive and low-cost interferometric biosensors due to the significant phase change achieved per unit propagation length.

**Index Terms:** Photonic integrated circuits, plasmonics, surface plasmons, directional coupling, plasmonic waveguide, silicon nitride, vertical integration.

## 1. Introduction

Co-integration of plasmonics with silicon photonics emerges as a key-enabling technology towards powerful photonic-integrated-circuits (PICs) combining the benefits of both technologies [1]–[7]. The unique feature of plasmonic waveguides to guide Surface-Plasmon-Polariton (SPP) modes at dimensions beyond the diffraction limit allows for increased light-matter interaction at the nanoscale, hence facilitating miniaturization of photonic devices. However, in most cases plasmonic waveguides exhibit high propagation losses preventing their broad deployment. To overcome this barrier, selective co-integration of plasmonic waveguides in restricted areas of low-loss silicon photonic chips, can mitigate the excessive optical loss coming from plasmonic structures while fully exploiting their functional benefits. An indicative application example where plasmonic waveguides may surpass the performance of photonic waveguides is optical biosensing. In such scenario, the predominant exposure of light at the metal surface offers unmatched refractive index sensing capabilities in micrometer scale propagation distances [8]. In this direction, open-cladded plasmonic

waveguides with strong field dependence on liquid loadings need to be integrated with low loss photonics in compact dimensions and by using simple fabrication methods.

Various in-plane plasmonic waveguides have been co-integrated so far with silicon [8]–[28] or silica-on-silicon photonics [29], targeting either mature classical or promising quantum sensing systems [30], [31]. Specifically, Metal-Insulator-Metal (MIM) or plasmonic slot-based waveguides have attracted significant research interest due to their ability to support deep sub-wavelength confined SPP modes as opposed to stripe based SPP waveguides with decreased mode confinement [29]. However, only a few approaches to demonstrate open cladded plasmonic slot waveguides topped with water have been so far investigated, employing silicon-based photonic waveguides to excite the SPP mode. A hybrid plasmonic mode was excited in a double slot configuration using waveguide tapering in [8] while vertical directional coupling combined with Fabry-Perot resonance was exploited in [9]. In both approaches the potential of hybrid plasmonic slot waveguides in integrated biosensors has been demonstrated further supporting the trend of plasmo-photonic integration. However, in the vertical coupling approach, the existence of the photonic waveguide below the plasmonic slot, forces the hybrid mode to oscillate between the photonic waveguide and the plasmonic slot throughout the complete cavity structure reducing the overall mode interaction with the cladding analyte. In fact, the transition of the mode from the photonic waveguide to the plasmonic slot for pure SPP propagation in the slot region requires the interruption of the photonic waveguide soon after the optical coupling length is met. To address the above requirement, in this work, we rely on our preliminary numerical design that was reported in [23] to demonstrate experimentally, a 150 nm thick gold (Au) based plasmonic slot waveguide cladded with water with a slot width of 210 nm being vertical directionally coupled with low-loss interrupted waveguides with cross-sectional dimensions of  $360 \times 800$  nm (height  $\times$  width). A  $\text{Si}_3\text{N}_4$  strip lying below a 660 nm thick oxide cladding ( $H_{\text{clad}}$  300 nm) was interrupted after a certain overlapping length with the plasmonic slot, allowing for the full utilization of the pure plasmonic SPP mode exposed on top of the structure in sensing applications. Experimental measurements in agreement with numerical simulations, revealed a photonic-to-plasmonic interface insertion-loss (I.L.) of  $2.24 \pm 0.3$  dB and a plasmonic propagation loss of 0.4 dB at 1550 nm, which translates to a plasmonic propagation length (defined as the power decay at  $1/e$ ) of  $10.8 \mu\text{m}$  in aqueous environment. The proposed plasmo-photonic waveguide requires a rather simplified and low-cost fabrication process by allowing the plasmonic slot to be deposited directly above the waveguide cladding avoiding any additional etching steps. In addition, compared to butt-coupled approaches, our directional coupling approach resulted in comparable insertion loss values [24]–[26], avoiding more challenging fabrication processes aiming at tapered structures with narrow taper-tips.

The rest of the paper is organized as follows. In Section 2, we present the optimized design and numerical simulations for the vertical photonic-to-plasmonic interface using a commercial available simulation software [32], [33]. Section 3, describes the fabrication process that was followed and the obtained experimental results after conducting broadband optical measurements using grating-couplers (GCs). In Section 4, we assess theoretically the sensitivity of the proposed waveguide in refractive index changes of the liquid cladding in an attempt to evaluate its potential in plasmo-photonic biosensor.

## 2. Design and Simulation

Fig. 1(a) illustrates a conceptual schematic of the proposed plasmo-photonic waveguide. The plasmonic slot waveguide is deposited on top of an oxide cladded  $\text{Si}_3\text{N}_4$  waveguide that is interrupted after a certain overlapping length with the plasmonic waveguide. When the photonic and the plasmonic waveguides overlap, a hybrid plasmonic slot waveguide is formed supporting two hybridized plasmonic-photonic modes with even and odd symmetries. In this state, a beating between those modes occurs allowing power exchange between the photonic and the plasmonic waveguides. The maximum power transfer that can be achieved between the photonic and the pure plasmonic SPP mode is predominantly determined by this overlapping length, named as coupling length ( $L_c$ ) following the principles of directional coupling mechanism [34].

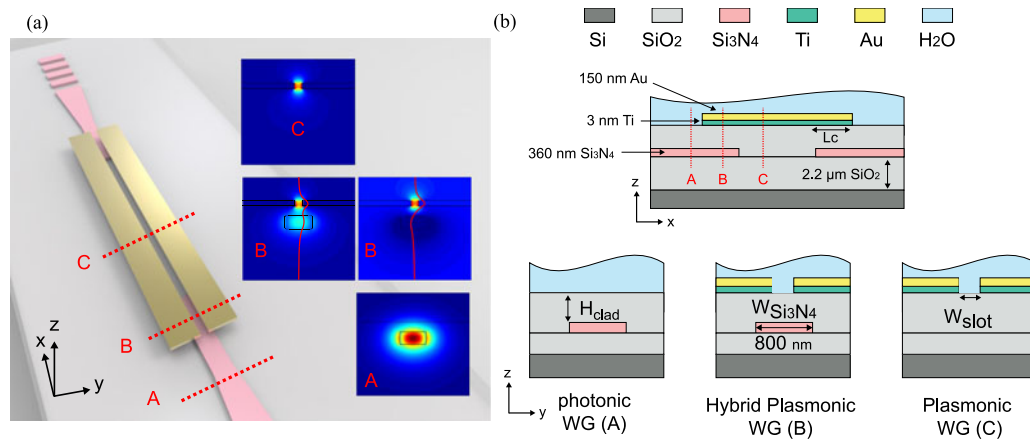


Fig. 1. (a) Conceptual schematic illustrating the vertically coupled plasmonic slot waveguide with  $\text{Si}_3\text{N}_4$  photonics and the evolution of a photonic mode along the direction of propagation until it is converted to the pure SPP mode. The gold based plasmonic slot waveguide is deposited on top of the oxide cladding of the  $\text{Si}_3\text{N}_4$  waveguide. Water is not shown for clarity. (b) Side-view and cross sections of the proposed plasmophotonic waveguide across the different stages of the structure.

A side-view representation of the investigated structure cladded with water, and the cross-sectional dimensions of the employed waveguides along the direction of propagation are shown in Fig. 1(b). More specifically, in our designs we considered a 150 nm thick Au based plasmonic slot waveguide lying on top of a 3 nm thick Ti layer which was used as an adhesion layer between the gold and the oxide cladding of the  $\text{Si}_3\text{N}_4$  waveguide. For the photonic waveguides, we employed a commercial available  $\text{Si}_3\text{N}_4$  waveguide platform developed by AMO GmbH, with  $360 \times 800$  nm strip based waveguides cladded with  $\text{SiO}_2$  (Low-Temperature-Oxide- LTO) lying on top of a  $2.2 \mu\text{m}$  thick  $\text{SiO}_2$ . The design parameters that we investigated based on our fabrication readiness was the height of the cladding in-between the  $\text{Si}_3\text{N}_4$  top surface and the bottom of the plasmonic waveguide ( $H_{\text{clad}}$ ) as well as the width of the plasmonic slot ( $W_{\text{slot}}$ ) waveguide.

In a first step, we conducted numerical simulations to calculate the effective refractive index ( $n_{\text{eff}}$ ) and the plasmonic propagation length (defined as the power decay at  $1/e - L_{\text{spp}}$ ) of the pure SPP mode for slot widths starting from 100 to 250 nm, using the commercial-grade simulator eigenmode solver of *Lumerical Solutions* software. We opted for a  $W_{\text{slot}}$  of 200 nm targeting at increased  $L_{\text{spp}}$  lengths and a plasmonic  $n_{\text{eff}}$  around 1.55 being close that of the photonic mode being 1.57 at 1550 nm. Fig. 2(a) presents the  $n_{\text{eff}}$  values as well as the  $L_{\text{spp}}$  lengths for the SPP mode. Secondly, we investigated more in detail the dependence of the  $n_{\text{eff}}$  of the hybrid modes that exhibit even and odd symmetries for various cladding thicknesses  $H_{\text{clad}}$  as presented in Fig. 2(b). The coupling length  $L_c$  required to achieve maximum energy transfer between the photonic and the pure SPP modes was estimated using the following relationship  $L_c = \frac{\pi}{\beta_{\text{even}} - \beta_{\text{odd}}}$ , where  $\beta$  is the propagation constant at 1550 nm. Next we performed full 3 D Finite-Difference-Time-Domain (FDTD) simulations to evaluate the I.L. of the plasmonic-to-photonic interface using the approximate  $L_c$  obtained for  $H_{\text{clad}}$  values of 200, 250, 300 and 350 nm. Fig. 2(c) presents the simulated I.L. for different  $L_c$  values suggesting a minimum I.L. of 1.35 dB at 1550 nm for  $H_{\text{clad}}$  of 300 nm. One would expect that the minimum I.L. would occur for the shortest  $L_c$ , therefore smaller  $H_{\text{clad}}$  values, however it was observed that a local minimum occurred for  $H_{\text{clad}}$  of 300 nm. This is attributed to the fact that, for smaller  $H_{\text{clad}}$  values, the I.L. increases due to the decreased overlap between the electric field intensity profiles of the photonic mode and the total coupled field at the front facet of the hybrid waveguide. For higher  $H_{\text{clad}}$  values  $L_c$  further increases, leading to higher I.L. as it was also reported in [34]. During simulations, the I.L. was determined after launching the quasi-TE mode of a  $360 \times 800$  nm strip based  $\text{Si}_3\text{N}_4$  waveguide and calculating the power that is coupled to the pure SPP mode.

That was realized by utilizing the built-in mode expansion monitors of *Lumerical Solutions* software to ensure that the forward propagating power is isolated and to calculate only the power that is

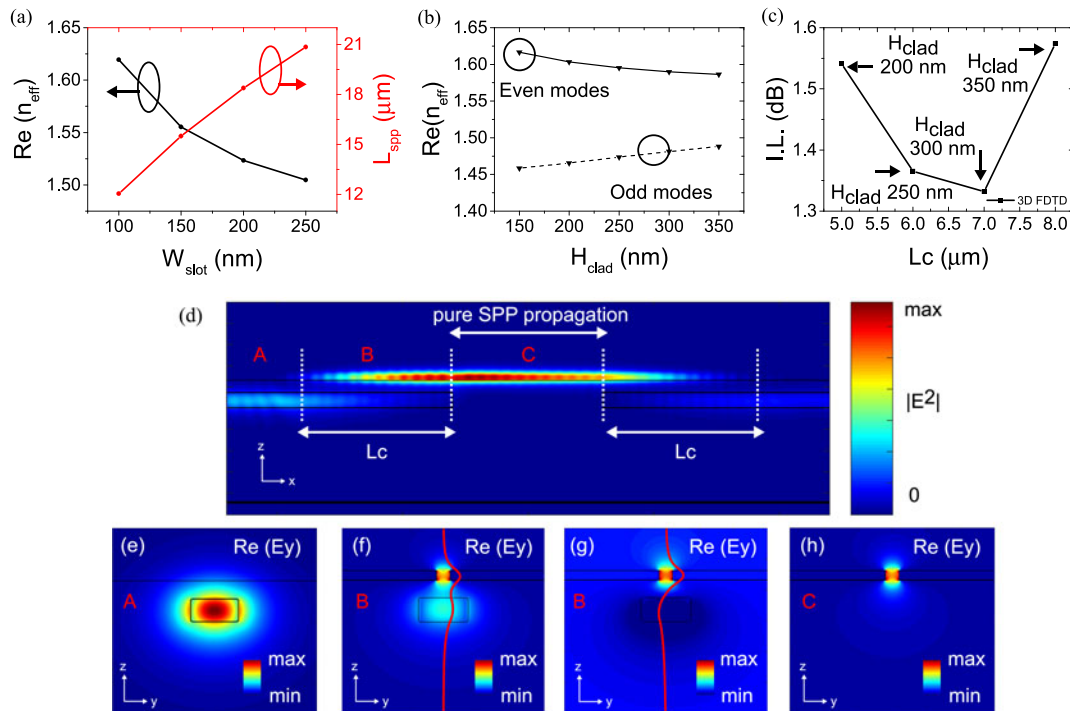


Fig. 2. (a) Effective refractive index ( $n_{\text{eff}}$ ) and plasmonic propagation length ( $L_{\text{spp}}$ ) for the SPP mode as function of  $W_{\text{slot}}$ . (b) Effective refractive index ( $n_{\text{eff}}$ ) versus cladding thickness for the even and odd modes and (c) simulated I.L. as a function of  $L_c$ . (d) Electric field intensity ( $|E^2|$ ) along the direction of propagation in the middle of the plasmo-photonic waveguide ( $y = 0$ ) for  $L_c$  of  $7 \mu\text{m}$ . (e)–(h) Electric field distribution  $\text{Re}(E_y)$  for photonic, even, odd and the pure SPP mode.

coupled into the pure SPP mode. This data was then normalized to the power of the photonic mode. For each investigated  $L_c$  value, the mode expansion monitor was settled  $2 \mu\text{m}$  away from the end facet of the plasmonic waveguide and the calculated I.L. was normalized by subtracting the induced SPP damping incorporated after  $2 \mu\text{m}$  of propagation. Fig. 2(d) illustrates the electric field intensity profile ( $|E^2|$ ) along the direction of propagation and in the middle of the plasmo-photonic waveguide ( $y = 0$ ). This graph shows how the photonic mode is converted to the pure SPP mode and back to the photonic mode by interrupting the photonic waveguides after an overlapping length equal to an  $L_c$  of  $7 \mu\text{m}$ . Fig. 2(e)–(h) show the electric field distribution ( $\text{Re}(E_y)$ ) for the photonic, even, odd and the pure SPP mode profile, respectively supported at the different stages of the structure. Finally, we investigated by means of numerical simulations (3 D FDTD) the tolerance of the plasmonic-to-photonic interface insertion loss for alignment errors of  $\pm 300 \text{ nm}$  between the slot and the  $\text{Si}_3\text{N}_4$  in the lateral direction [i.e.,  $y$ -direction as it is denoted in Fig. 1(a)]. Numerical simulations have shown an increase of 1 dB for the plasmo-to-photonic interface insertion loss considering an alignment error of  $300 \text{ nm}$ . The refractive indices used in the simulations for the  $\text{Si}_3\text{N}_4$ , LTO,  $\text{SiO}_2$  and water at  $1.55 \mu\text{m}$  were 1.996, 1.444, 1.444 and  $1.311 - 0.0001348i$ , respectively [35], [36]. During simulations we used the same refractive index value for both the LTO and the  $\text{SiO}_2$  layers. The complex refractive indices used for gold and Ti at  $1.55 \mu\text{m}$  were  $0.26 - 11i$  and  $4.04 - 3.82i$ , respectively [37], [36].

### 3. Fabrication and Measurement Results

The silicon nitride waveguides and grating couplers (GCs) were fabricated using standard 6" silicon wafers with  $2.2 \mu\text{m}$  of thermally grown  $\text{SiO}_2$  and optical projection lithography. The  $360 \text{ nm}$  thick



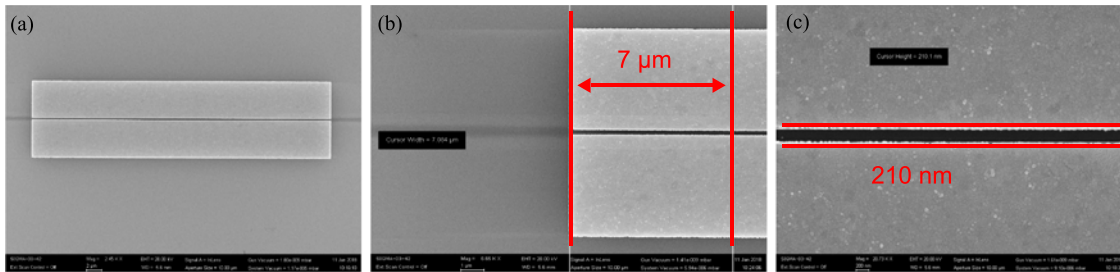


Fig. 3. SEM images. (a) Top-view of the plasmonic slot waveguide deposited on top of the  $\text{Si}_3\text{N}_4$  waveguide. Close-up view for (b) the fabricated plasmonic waveguide with an  $L_c$  of  $7\ \mu\text{m}$  and (c) the plasmonic slot with a  $W_{\text{slot}}$  of  $210\ \text{nm}$ .

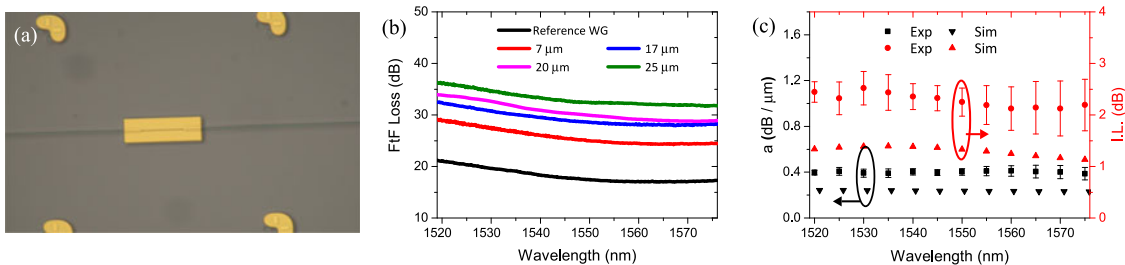


Fig. 4. (a) Microscope image depicting a plasmonic slot waveguide on top of an oxide cladded  $\text{Si}_3\text{N}_4$  waveguide. (b) FIF loss budget for the measured test structures (c) Experimental and simulated I.L. and plasmonic propagation loss as function of wavelength in water.

$\text{Si}_3\text{N}_4$  waveguide layer has been deposited in a low-pressure-chemical-vapor-deposition-process (LPCVD). Waveguide structures and markers have been defined by an i-line stepper tool. Reactive ion etching with  $\text{CHF}_3$  and He chemistry was used for the structure transfer. Then  $660\ \text{nm}$  of  $\text{SiO}_2$  (Low-temperature-oxide - LTO) was deposited by LPCVD for the cladding layer. To improve the  $\text{SiO}_2$  quality and avoid additional losses, due to hygroscopic properties, the wafers have been annealed for several hours at  $1000\ ^\circ\text{C}$ . Planarization of the  $\text{SiO}_2$  surface was done by spin coating spin-on-glass (SOG) and subsequent etching in  $\text{CHF}_3$  plasma. The process cycle of SOG coating and dry etching was repeated twice, leaving only a level difference less than a few tens on nanometers above the LTO surface and away from silicon nitride waveguides. The plasmonic slot waveguides were deposited by a lift-off process using e-beam lithography, thermal evaporation of gold and lift-off. The e-beam lithography has been performed at  $20\ \text{kV}$  acceleration voltage on a  $\sim 220\ \text{nm}$  thick Allresist CSAR62 resist coating. In this stage the alignment was based on the recognition of the markers that were previously patterned in the  $\text{Si}_3\text{N}_4$  layer covered with LTO. Resist development took place in the AR600-546 developer, followed by rinsing in AR600-60. Before metal evaporation a descumming stage was also realized for 2 minutes in an oxygen-plasma cleaner. The target thickness for gold was  $150\ \text{nm}$ .

A very thin ( $3\ \text{nm}$ ) titanium layer has been deposited by e-gun evaporation prior to the gold layer for an improved adhesion of Au on the sample. The lift-off process has been realized in AR600-71 remover bath and the final rinsing in acetone and isopropanol. Scanning-Electron-Microscope (SEM) images for the fabricated structure are shown in Fig. 3.

Fig. 3(a) illustrates a top-view of the deposited plasmonic slot waveguide on top of the photonic waveguide, while Fig. 3(b) and (c) show a close-up view of the fabricated samples with a  $W_{\text{slot}}$  of  $210\ \text{nm}$ . Fig. 4(a) shows a microscope image of the fabricated plasmo-photonic waveguide. In order to measure the plasmonic propagation loss in water and the I.L. of the photonic-to-plasmonic interface, we fabricated test structures with different lengths ( $7$ ,  $17$ ,  $20$  and  $25\ \mu\text{m}$ ) of the pure plasmonic part of the waveguide and  $W_{\text{slot}}$  of  $200\ \text{nm}$ . Among the test structures we incorporated

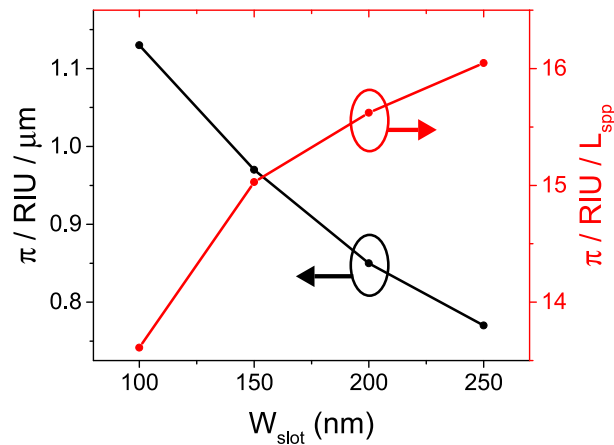


Fig. 5. Simulated accumulated phase change of the SPP mode over propagation distances of one micron (left-black) and one  $L_{\text{spp}}$  (right-red) as a function of  $W_{\text{slot}}$ .

a reference waveguide comprising of a 1 cm long straight  $\text{Si}_3\text{N}_4$  waveguide. During optical characterization we carried out cut-back measurements by sweeping the wavelength of a tunable laser source from  $1.52 \mu\text{m}$  to  $1.575 \mu\text{m}$ . Fig. 4(b) presents results for the fiber-to-fiber (FtF) loss budget of the characterized test structures as a function of wavelength. The plasmonic propagation losses in water were calculated for wavelengths ranging from  $1.52 \mu\text{m}$  to  $1.575 \mu\text{m}$  with a step of 5 nm, performing least-squares linear fitting on the FtF loss budget data of the interface test structures with increasing slot length. Fig. 4(c) shows the plasmonic propagation loss in water as a function of wavelength, revealing  $0.4 \text{ dB}/\mu\text{m}$  losses at  $1.55 \mu\text{m}$ , that correspond to an  $L_{\text{spp}}$  of  $10.85 \mu\text{m}$ , closely following the theoretically predicted value of  $0.24 \text{ dB}/\mu\text{m}$ . The error bars correspond to the standard deviation deduced from the linear fitting process. To calculate the insertion loss of the photonic-to-plasmonic interface I.L. per single transition, the FtF losses of the reference  $\text{Si}_3\text{N}_4$  waveguide structure were subtracted from the intercept values obtained by this linear fitting process and the resulting loss value was divided by a factor of two. The experimental I.L. that was derived from this calibration process is depicted in Fig. 4(c), showing a value of  $2.24 \pm 0.3 \text{ dB}$  at  $1.55 \mu\text{m}$ . Fig. 4(c) shows also the numerical results obtained from broadband simulations for a single vertical transition. Broadband simulations were performed taking into account the dispersive properties of gold, revealing interface losses of  $1.35 \text{ dB}$  at  $1.55 \mu\text{m}$ , being in good agreement with experimentally obtained data.

#### 4. Sensing Simulation

Following the good agreement between theory and experiment we investigate theoretically the sensitivity of the proposed plasmo-photonic waveguide to refractive index changes of the applied liquid cladding by calculating the accumulated phase change per refractive index unit (RIU) over a propagation distance equal to an  $L_{\text{spp}}$  length of  $18.3 \mu\text{m}$ . This investigation estimates the potential benefits of this plasmo-photonic waveguide in biosensing applications if embedded in interferometric sensor layouts. A refractive index change ( $\Delta n$ ) of 0.01 was introduced during simulations to the overlying water and the numerical results revealed a SPP mode with an effective index  $n_{\text{eff}}$  of 1.521 at  $1.55 \mu\text{m}$ , increased by  $\Delta n_{\text{eff}} = 0.006$  compared to its initial value with unperturbed aqueous solution. Using this  $\Delta n_{\text{eff}}$  value, the accumulated phase change over a length of  $L_{\text{spp}}$  is calculated to be  $0.85 \pi$  for a  $\Delta n = 10^{-2}$ , which translates to  $15.6 \pi / \text{RIU} / L_{\text{spp}}$  or, alternatively, to  $0.85 \pi / \text{RIU} / \mu\text{m}$ . Fig. 5 presents the simulated phase change of the proposed plasmo-photonic waveguide accumulated over propagation distances equal to one micron or one  $L_{\text{spp}}$  for different  $W_{\text{slot}}$  values. Typical experimental results reported for photonic sensing waveguides hardly exceed

0.27  $\pi$ /RIU/ $\mu\text{m}$  [38], using photonic slot configurations. In this context, the proposed waveguide solution presents a clear advantage towards realizing compact and highly sensitive sensors by tripling phase change accumulation per unit length when compared to photonic counterparts.

## 5. Conclusion

We have demonstrated, the design, fabrication and experimental characterization of water cladded Au-based plasmonic slot waveguides vertical coupled with interrupted  $\text{Si}_3\text{N}_4$  waveguides at 1550 nm. Experimental measurements being in agreement with numerical simulations revealed a photonic-to-plasmonic I.L. of  $2.24 \pm 0.3$  dB and an  $L_{\text{spp}}$  of 10.8  $\mu\text{m}$  at 1550 nm. Numerical simulations suggested also an accumulated phase change of 15.6  $\pi$ /RIU/ $L_{\text{spp}}$  or 0.85  $\pi$ /RIU/ $\mu\text{m}$  in the pure plasmonic waveguide clearly highlighting the promise of the proposed waveguide when used as the optical transducer in compact and highly sensitive interferometric biosensors.

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